

Search Notes

Application No.

10/028,712

Examiner

Wesley D Markham

Applicant(s)

FURUSAWA ET AL.

Art Unit

1762

SEARCHED

Class	Subclass	Date	Examiner
427	552	11/4/2003	WM
427	553	11/4/2003	WM
427	555	11/4/2003	WM
427	558	11/4/2003	WM
427	226	11/4/2003	WM
427	248.1	11/4/2003	WM
427	255.18	11/4/2003	WM
427	255.23	11/4/2003	WM
427	256	11/4/2003	WM
427	258	11/4/2003	WM
427	259	11/4/2003	WM
427	261	11/4/2003	WM
427	264	11/4/2003	WM
427	265	11/4/2003	WM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor and Assignee search	11/4/2003	WM
Consulted Tim Meeks, primary, AU 1762, about art of using SAMs as CVD masking layers	11/4/2003	WM
EAST search, all databases	11/4/2003	WM

Search Notes (continued)

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Class	Subclass	Date	Examiner
427	270	11/4/2003	WM
427	271	11/4/2003	WM
423	348	11/4/2003	WM
423	349	11/4/2003	WM
117	88	11/4/2003	WM
117	95	11/4/2003	WM
438	503	11/4/2003	WM
438	507	11/4/2003	WM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR